## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination RABIE ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,104,700 A	08-2000	Haddock et al.	370/235
*	В	US-6,298,059 B1	10-2001	St-Amand et al.	370/397
*	C	US-2002/0172158 A1	11-2002	Hoefelmeyer et al.	370/241
*	D	US-2003/0048792 A1	03-2003	Xu et al.	370/400
*	Ε	US-6,606,660 B1	08-2003	Bowman-Amuah, Michel K.	709/227
*	F	US-6,640,249 B1	10-2003	Bowman-Amuah, Michel K.	709/228 .
*	G	US-2004/0078469 A1	04-2004	Ishwar et al.	709/227
*	Н	US-2004/0081093 A1	04-2004	Haddock et al.	370/230
*	-	US-2004/0111461 A1	06-2004	Claudatos et al.	709/200
*	J	US-2005/0013244 A1	01-2005	Parlos, Alexander G	370/229
*	К	US-7,020,697 B1	03-2006	Goodman et al.	709/223
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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